

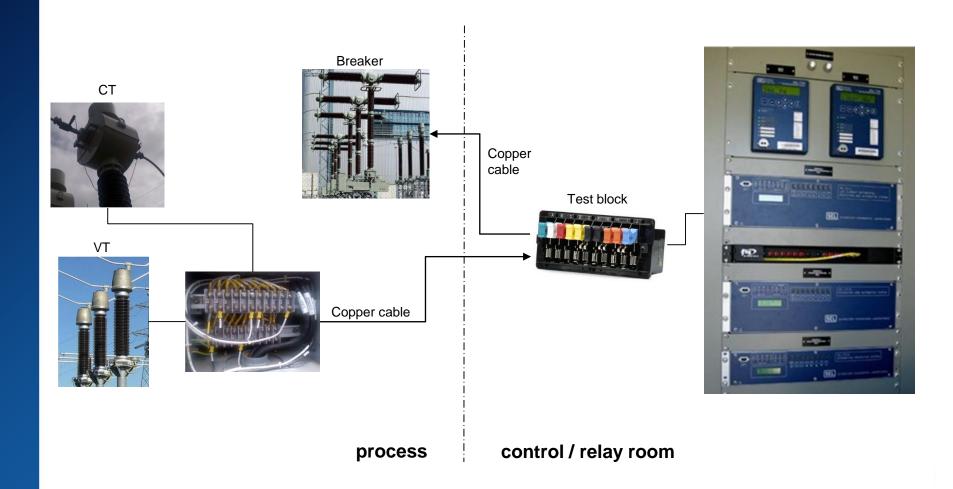


Testing Protection, Automation and Control

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Boot Camp IEC 61850 IOP 2019-09-22, Charlotte, NC

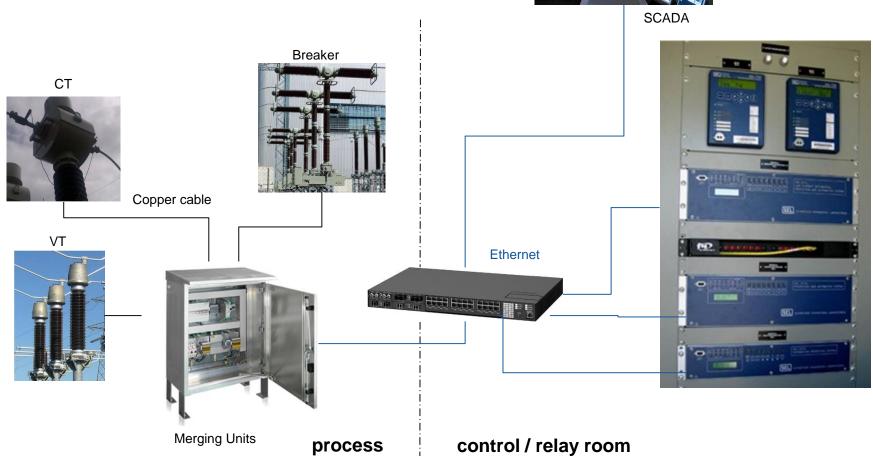
Evolution from Conventional to Digital Substations



Evolution from Conventional to Digital Substations

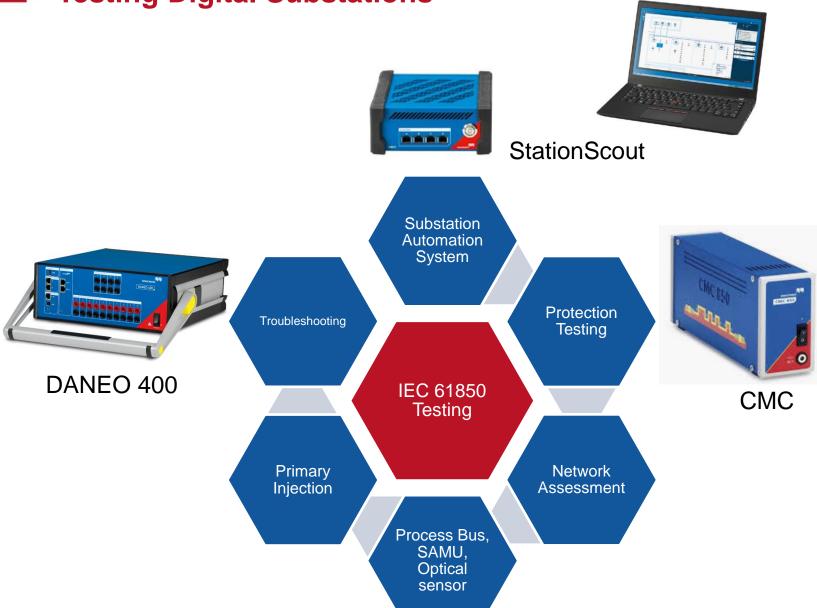
> Move Analog and Physical I/O to the yard





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Testing Digital Substations



Testing Digital Substations

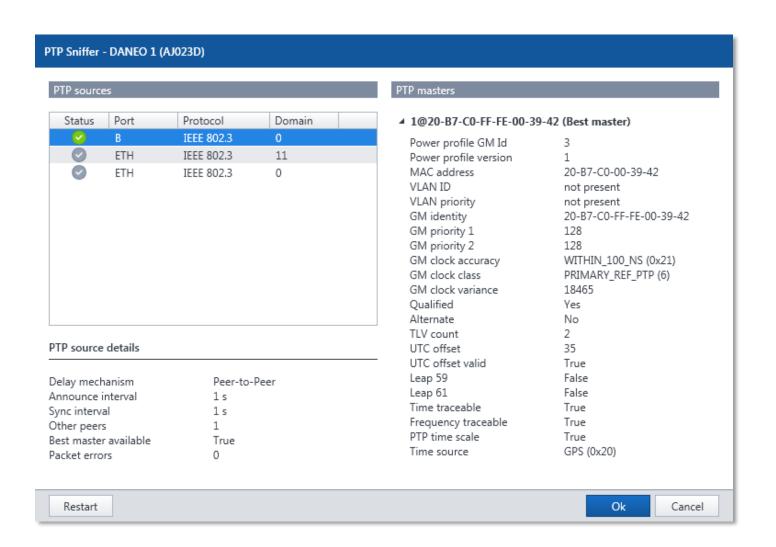
- > Troubleshooting live system:
 - > PTP
 - > Process Bus
 - > Network Supervision
- > Testing the Substation Automation System:
 - > Testing Communication
 - > Testing Control and Interlocking Logics
 - > Checking IED Health Status
- > Protection Testing:
 - > MMS: Control Test Mode (DO Mod) and Simulation (DO Sim)
 - > GOOSE and SV

Portable Digital Fault Recorder for Troubleshooting

- > Hybrid and distributed measurement and recording
- > **Live observation** of values and IEC 61850 messages
- > Time signal and traffic analysis
- > Measurement of **propagation delays**
- > System **supervision** and event notification
- > **Documentation** of results



Time synchronization testing: PTP Sniffer

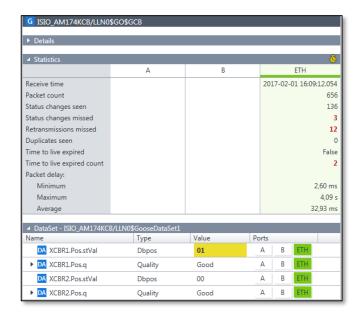


Observation – Live View of Data

- > Measurement of live values and most recent history
- > Oscilloscope view, phasor diagrams, harmonics spectrum...
- > GOOSE and SV data values and statistics



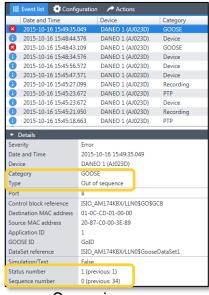
Live values and recent history



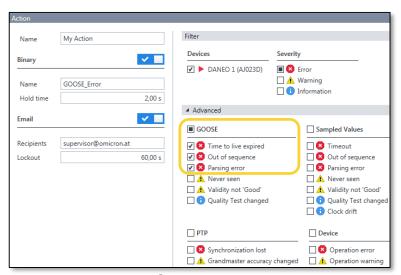
GOOSE data values and statistics

Supervision of Network Traffic

- > Supervisor event list with details about events
- > Actions for triggering recordings or sending email notifications



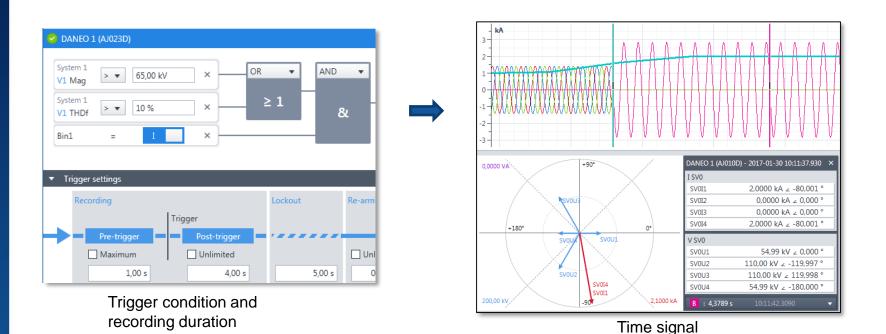
Supervisor event list



Supervisor actions

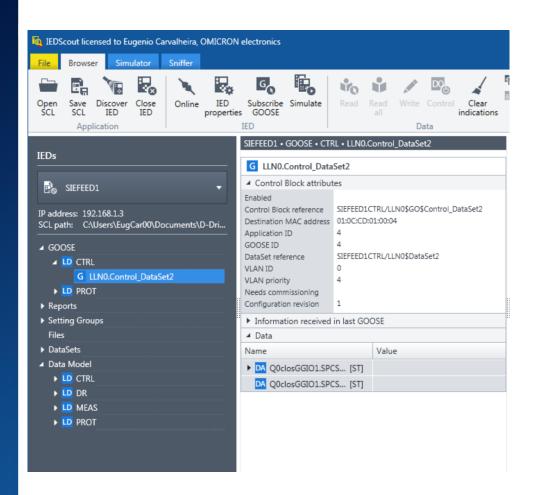
Recording – Time Signal Analysis

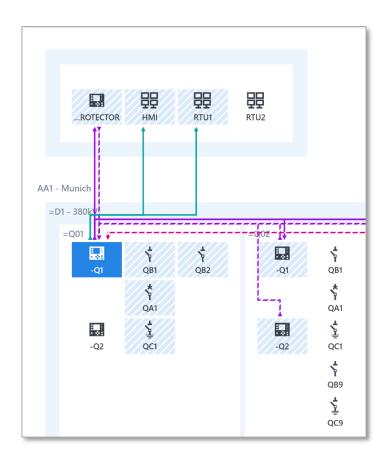
- > Configuration signals and network traffic for capturing
- > Definition of trigger condition and recording duration



analysis

A different View of the Substation Automation System



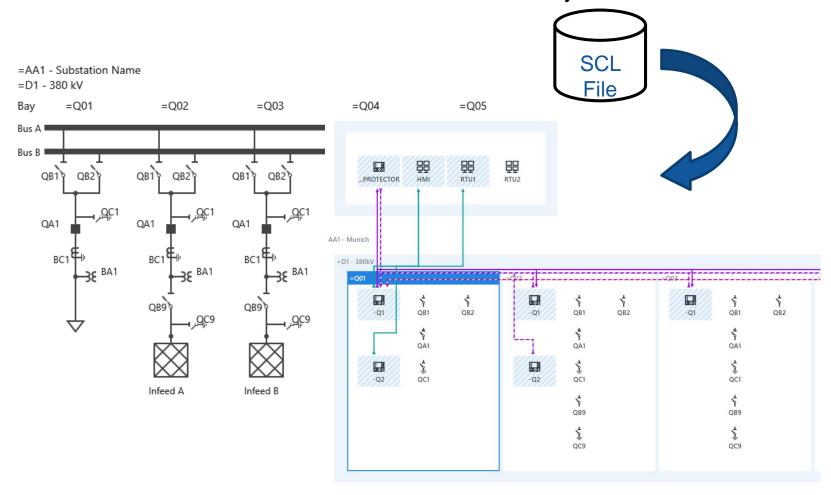


> The IED's View

> The Station's View

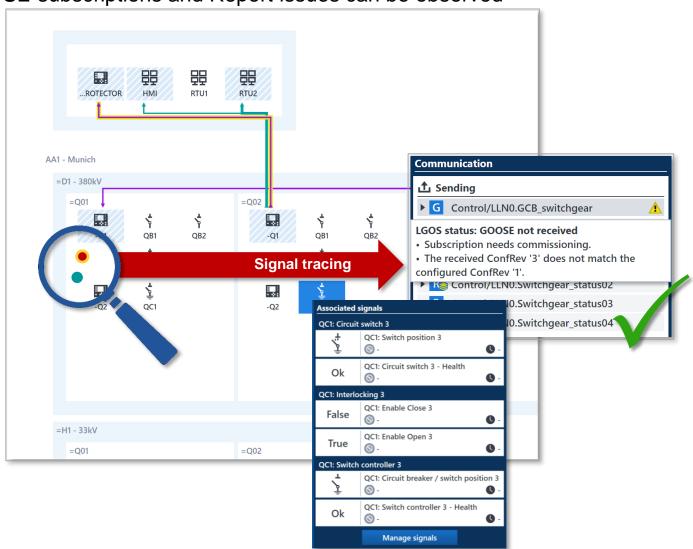
Testing the SAS

- > Based on SCL Information
- > Visualize and Test entire Substation Automation System



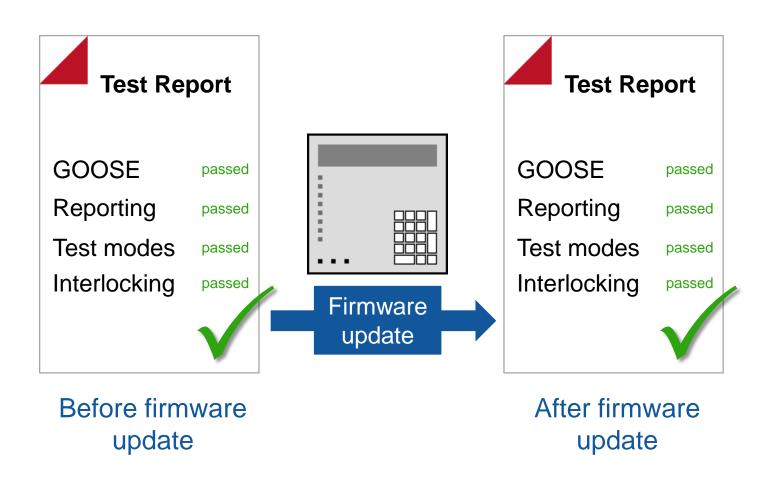
Smart Overview with signal tracing

- > Smart Overview visualizes communication links and status information of IEDs and primary assets
- > GOOSE subscriptions and Report issues can be observed





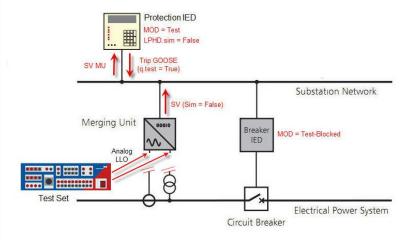
Testing after firmware update

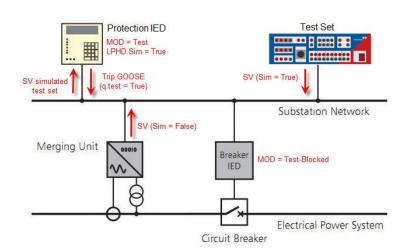


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Protection Testing in Digital Substations

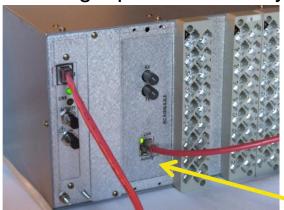
- > Different scenarios:
 - > Commissioning, maintenance...
 - > Utility procedures
- > Combined Protection + Metering Circuit + IO Check
 - > Secondary Injection at MU
 - > Monitor Trip/Close at physical output of Breaker IO
 - Monitor Breaker status at Breaker IO GOOSE
- > Test subsystems separately:
 - > Primary injection at CT/VT and check SV
 - > Test Protection IED by injecting SV and monitoring GOOSEs





Protection Testing Challenges

> Where are the analog inputs in the relay?



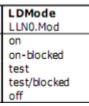
> Where is the test switch?



> How to isolate the relays under test?

Protection Testing: Test Isolation

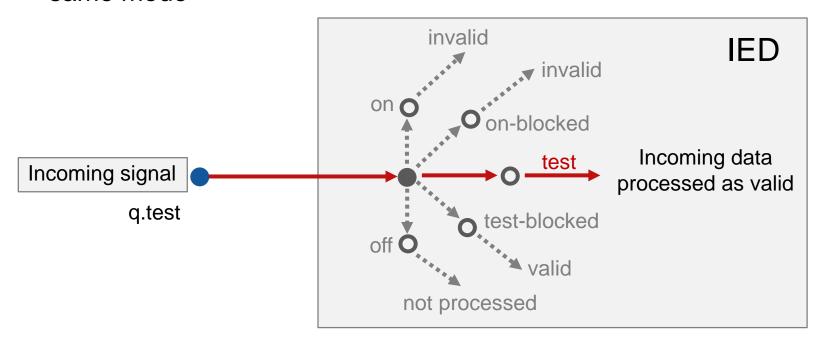
- > IEC 61850 Edition 2 defines functionalities supporting isolation for testing
- > Separating Test and Normal information
 - > Data Object Mod and Beh in IED
 - > "Test bit" in Quality attribute q.test



- > Separating Simulated and Normal messages
 - > Simulation flag in GOOSE and SV messages
 - > Data Object LPHD.Sim in IED

Test Mode: separating Test and Normal information

- > Test mode can be available per logical **node** like PROTECTION.PDIS1, per logical **device** like PROTECTION or for entire IED
- > More than a simple "Test mode":
 - > on; on/blocked; test; test/ blocked; off
- Incoming signal is only accepted if sender and receiver are in the same mode



Test Features

> Test Mode of a function...

LNMode	LDMode	LNBeh (read only)	LNBeh
XXXX.Mod	LLN0.Mod	XXXX.Beh	Value
on	on	on	1
on	on-blocked	on-blocked	2
on	test	test	3
on	test/blocked	test/blocked	4
on	off	off	5
on-blocked	on	on-blocked	2
on-blocked	on-blocked	on-blocked	2
on-blocked	test	test/blocked	4
on-blocked	test/blocked	test/blocked	4
on-blocked	off	off	5
test	on	test	3
test	on-blocked	test/blocked	4
test	test	test	3
test	test/blocked	test/blocked	4
test	off	off	5
test/blocked	on	test/blocked	4
test/blocked	on-blocked	test/blocked	4
test/blocked	test	test/blocked	4
test/blocked	test/blocked	test/blocked	4
test/blocked	off	off	5
off	on	off	5
off	on-blocked	off	5
off	test	off	5
off	test/blocked	off	5
off	off	off	5

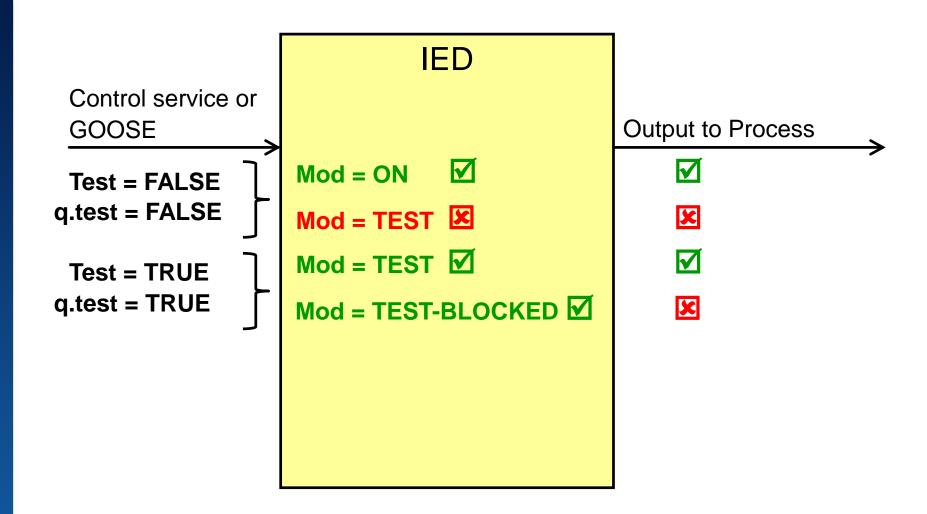
Test Features

- > GOOSE/Control for test purpose...
 - > test bit in Quality (q) attribute

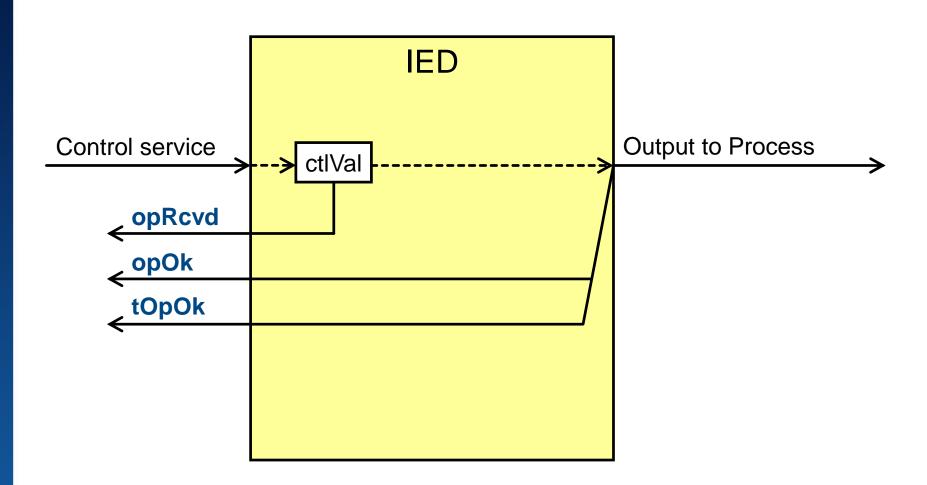
MODE/BEHAVIOUR	on	on-blocked	test	test/blocked	off
Function behind LN	ON	ON	ON	ON	OFF
Output to the Process (Switchgear) via a non- IEC 61850 link for example wire (typical for X,Y and GGIO LNs)	YES	NO	YES	NO	NO
Output of FC ST, MX (issued independently from Beh)	value is relevant q is relevant	value is relevant q is relevant	value is relevant q.test=true	value is relevant q.test=true	value is irrelevant q.validity=invalid
Response to (Normal) Command from Client (a+ / a- acknowledgement)	a+ pos. ack.	a- neg. ack.	a- neg. ack.	a- neg. ack.	a- neg. ack.
Response to TEST Command from Client (a+ / a- acknowledgement)	a- neg. ack.	a- neg. ack.	a+ pos. ack.	a+ pos. ack.	a- neg. ack.
Incoming data with q=normal	Processed as valid	Processed as valid	Processed as valid	Processed as valid	Not Processed
Incoming data with q=operatorBlocked	Processed as blocked	Processed as blocked	Processed as blocked	Processed as blocked	Not Processed
Incoming data with q=test	Processed as invalid	Processed as invalid	Processed as valid	Processed as valid	Not Processed
Incoming data with q=test+operatorBlocked	Processed as invalid	Processed as invalid	Processed as blocked	Processed as blocked	Not Processed
Incoming data with q=invalid	Processed as invalid	Processed as invalid	Processed as invalid	Processed as invalid	Not Processed
Non-IEC 61850 binary (relay, contact) inputs and analogue (instrument transformer) inputs	Processed	Processed	Processed	Processed	Not Processed

NOTE A precondition of the use of different modes (Mod/Beh) is the processing of the quality status (q) of the receiving information.

Test bit and Test Mode

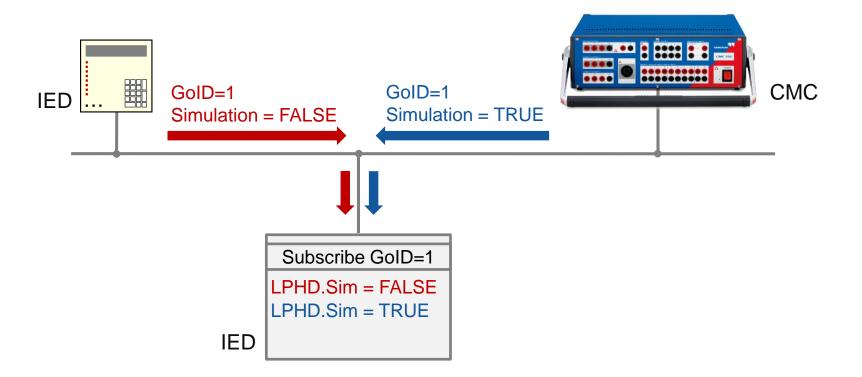


Mirroring of Control Service Requests



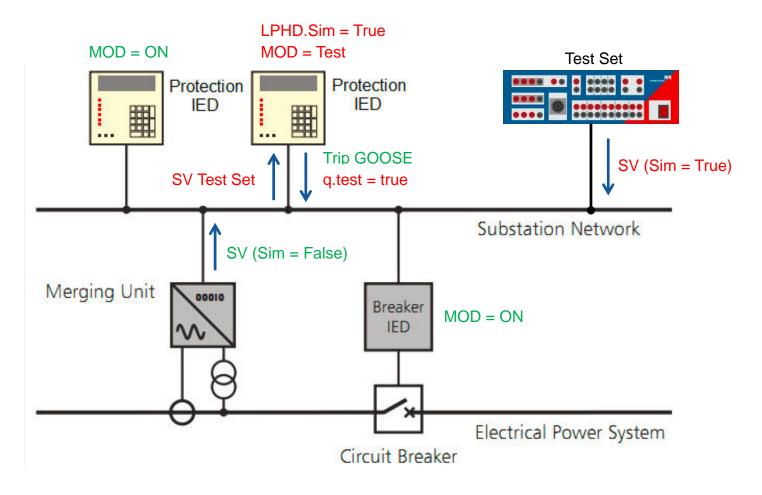
Separating Simulated and Normal messages

- > How to distinguish between "real" signals and simulated ones?
- > Simulation flag bit at GOOSE and SV Ethernet frame
- > Sets the entire IED ("physical device") in simulation mode LPHD.Sim = True

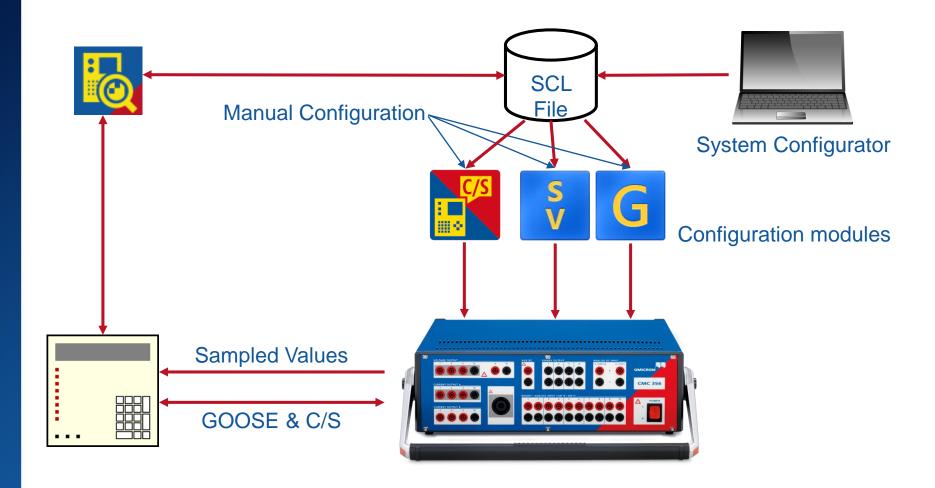


Complete Test Isolation

> Simulation Flag and Test Mode

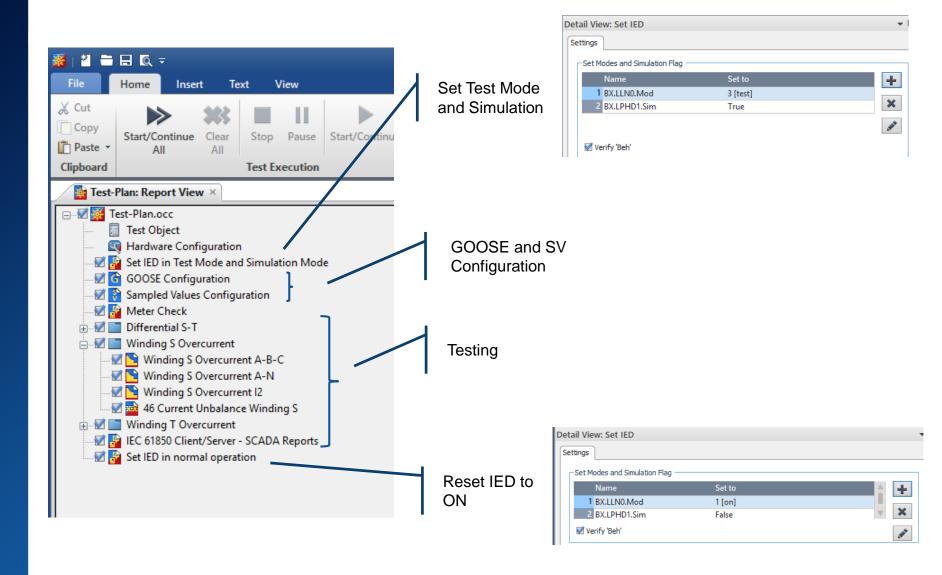


Protection IED Testing





Test Plan example



Thanks!